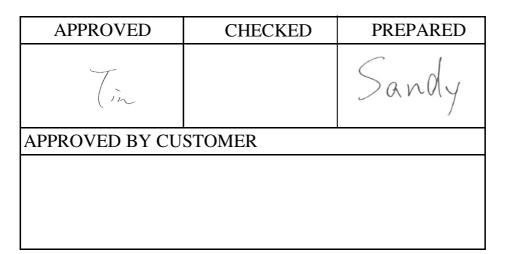
APPROVAL SHEET

Customer Name	:
Customer P/N	:
Frequency	:8.000000 MHz
Aker Approved P/N	V:CXA-008000-5X4X43
Aker MPN	:CXA-008000-5X4X43
Rev.	:1
ISSUE DATE	: Nov.26.2019



AKER TECHNOLOGY CO., LTD.

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TEL: 886-4-25335978 FAX: 886-4-25336011

Web: www.aker.com.tw

RoHS compliant

Aker Approved P/N : CXA-008000-5X4X43 APPROVED :: Tin SHEET : 1 of 9 PREPARED :: Sandy REV. : 1 Rev. Date Reviser 1 2019/11/26 Sandy Initial Released Image: Sandy in the image is a straight of the image is a strain a straight of the image is a straight of				JST. P/N	:		
Accurate Kinetic Energy PREPARED : Sandy REV. : 1 Rev. Date Reviser Revise contents			Ak	er Approved	P/N :		
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	Accura	ate Kinetic Energy	PR	EPARED	•	Sandy	REV. : 1
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CUST. P/N	:		
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APPROVED	:	Tin	SHEET : 2 of 9
PREPARED	:	Sandy	REV. : 1

SMD CRYSTAL SPECIFICATION

1. ELECTRICAL CHARACTERISTICS

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature : 25 ± 5 °C

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : 25 ± 3 °C

Relative humidity : 40%~70%

- AKER Model : CXA-531
- Oscillation Model : Fundamental
- Cutting Model : AT CUT
- Measurement Equipment : 350A(Measured FL)
- Insulation Resistance : More than 500M ohms at DC 100V

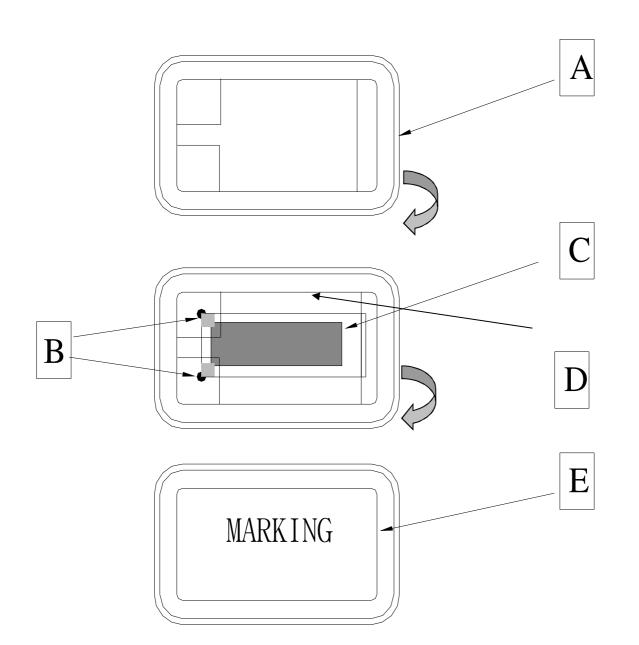
		Electrical Spec				
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes
Nominal Frequency	FL	8	3.000000)	MHz	
Frequency Tolerance			±30		ppm	at 25° C ± 3° C
Frequency Stability			±30		ppm	Operating Temp (Refer 25°C)
Load Capacitance	CL		20		pF	
Aging			±3		ppm	First Year
Operating Temperature		-40	\sim	85	°C	
Storage Temperature Range		-55	\sim	125	°C	
Drive Level	DL			100	uW	
Effective Resistance Rr	Rr			80	Ω	
Shunt Capacitance	C0			5	pF	
Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.						

	CUST. P/N					
	Aker Approve	· 		08000-5X	11112	
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	APPROVED	•	Tin	SH	EET : 3 of	9
Accurate Kinetic Energy	PREPARED	:	Sandy	RE	V. : 1	
2. MARKING :						
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*	Year	2019	2020	2021	2022	
Production line	e code 🔪	2023	2024	2025	2026	
		2027	2028	2029	2030	
	Month	2031 2035	2032 2036	2033 2037	2034 2038	
	JAN	2035 A	2036 N			
	FEB	B	P N	a b	n	
	MAR	В С	Q P	c b	p	
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	Tin	SHEET: 4 of 9
	Sandy	REV. : 1
-		1

4. STRUCTURE ILLUSTRATION

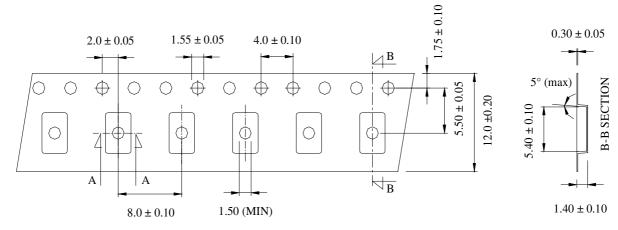


	COMPONENTS MATERIALS		COMPONENTS		MATERIALS
А	Base (Package)	Ceramic(Al2O3)+Kovar(Fe/Co/Ni)	D	Electrode	Cr / Ag
В	Conductive adhesive	Ag / Silicon resin	Е	Lid	Fe/Co/Ni
С	Crystal blank	SiO2			

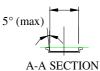
	CUST. P/N	:		
	Aker Approved P/N	:	CXA-00800	0-5X4X43
	APPROVED	:	Tin	SHEET : 5 of 9
Accurate Kinetic Energy	PREPARED	:	Sandy	REV. : 1

5. PACKING : TAPE SPECIFICATION

(Unit:mm)

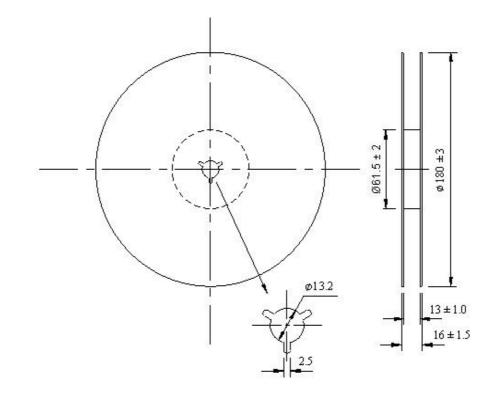


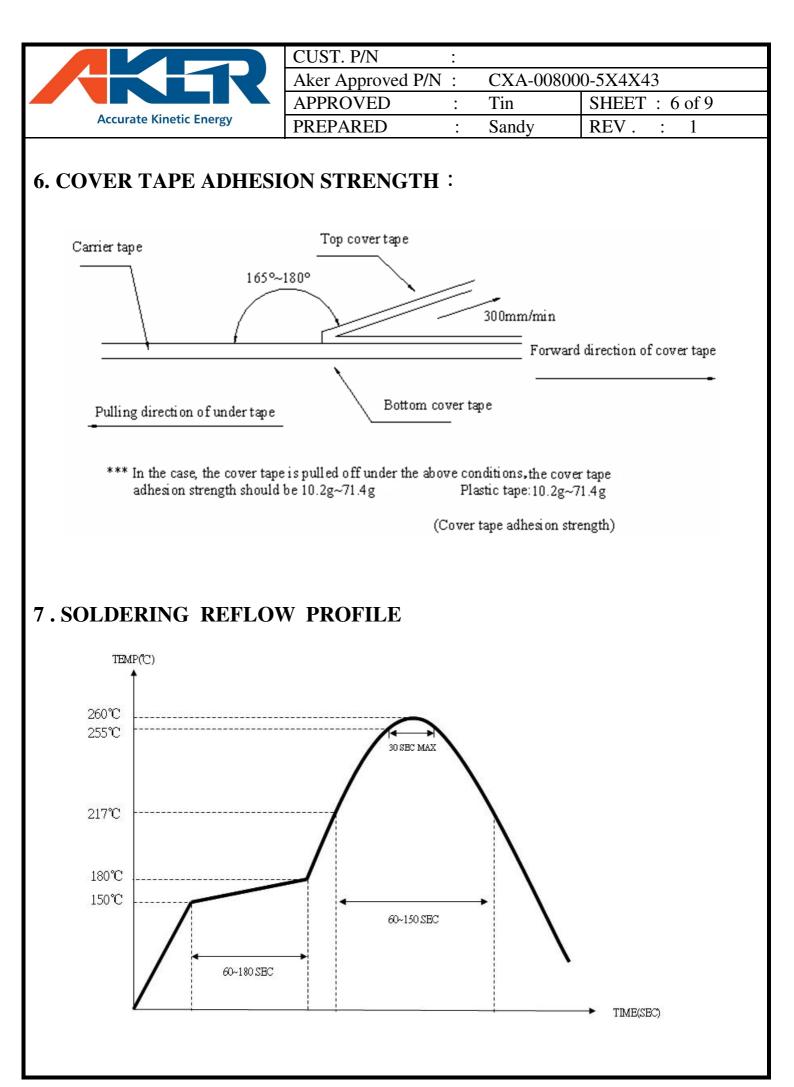
 3.60 ± 0.10

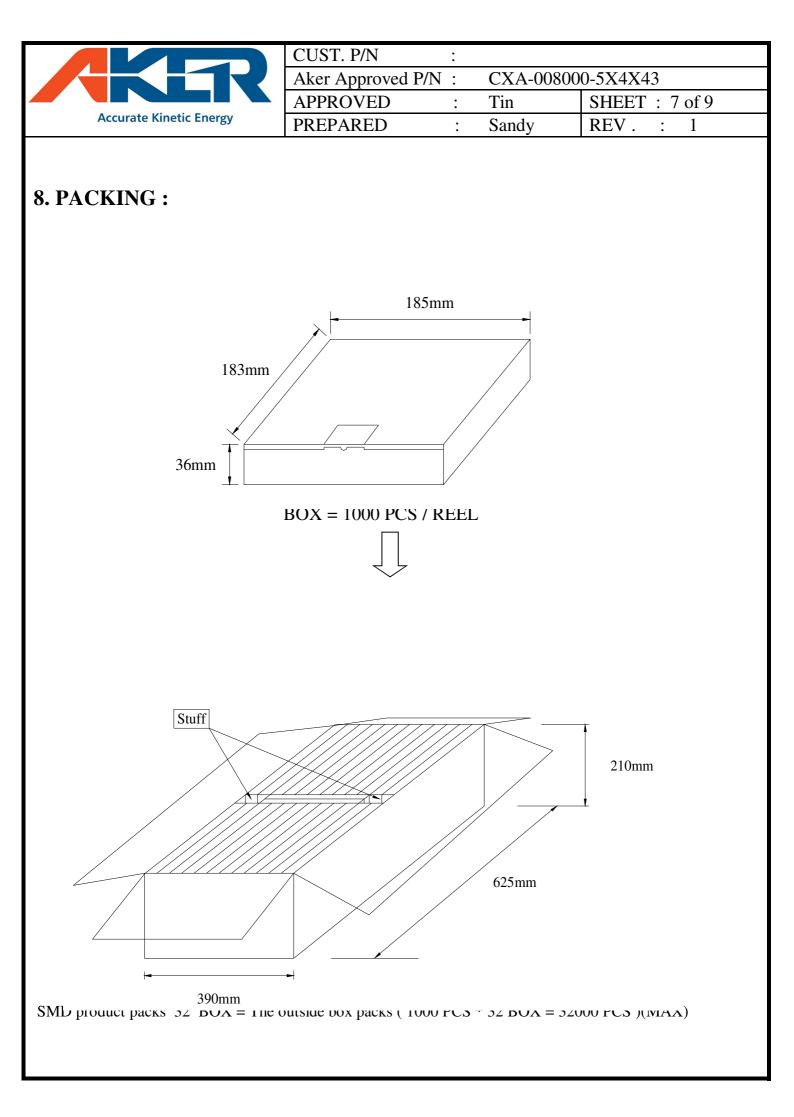


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(Umi : mm)









CUST. P/N :		
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APPROVED :	Tin	SHEET : 8 of 9
PREPARED :	Sandy	REV. : 1

9. MECHANICAL PERFORMANCE

	NICAL PERFORMANCE	
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
9.1 Drop Test	The specimen is measured for its frequency and resistance before the test. It is then dropped from a hight of 100 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. (in accordance with JIS-C0044)	
9.2 Vibration Test	The specimen is measured for its frequency and resistance before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range ; $20 \ 2000$ HZ Peak to peak amplitude : 1.52 mm Peak acceleration : 20G Sweep time : 20 minute / axis Pendicular total test time : 4 hours (in accordance with MIL_STD_883E : 2007.3)	To satisfy the electrical performance .
9.3 Resistance to Soldering Test	(in accordance with MIL-STD-883F : 2007.3) The specimen is measured for its frequency and resistance before the test. Place the specimen on the belt of the converynace and let it pass through the reflow with the presetted temperature condition. After passing twice the reflow place, the specimen under the referee condition for -~2 hours and then measure its electrical performance. Temperature Condition of IR Simulation: The temperature range of the preheated section is setted at 150 $^{\sim}$ 180°C for 60~120 sec. For the next section the temperature range is setted at 217~260°C for 45~90 sec. and within this time range the specimen should be able to sustain at the peak temperature, 260+/-3°C , for 10 sec long. (in accordance with JESD22-B106-B)	
9.4 Fine Leak Test	Place the specimen in a pressurized container and pressurize it with the detection gas (mixed gas consisting of 95% or more helium) for at least 2 hours. Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container. (in accordance with MIL-STD-883F: 1014.11)	Less than 1.0 * 10 ⁻⁸ atm .c.c. / sec, Helium
	The referee condition . Temperature 25 ± 2 °C Humidity $44 \approx 55 \%$ Pressure $86 \approx 106$ kPa (in accordance with MIL-STD-883E : 1014. 9)	



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10. CLIMATIC RESISTANCE

	IC RESISTANCE	
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
10.1 Low Temp Exposure Test	The specimen is measured for its frequency and resistance before the test . Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for 168 ± 6 hours . Take the specimen out of the chamber and measure itselectrical performance after leaving 1 ~ 2 hours under the referee condition. (in accordance with JIS-C0020)	
10.2 Aging Test	The specimen is measured for its frequency and resistance before the test . Place the specimen in the testing chamber and keep it at the temperature of $+ 125 \pm 3^{\circ}$ C for 720 ± 48 hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for $1 \sim 2$ hours under the referee condition . (in accordance with JIS-C0021)	To satisfy the electrical performance .
10.3 High Temperature & High Humidty	The specimen is measured for its frequency and resistance before the test . Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5$ °C and humidity of 85 ± 5 % for 168 ± 6 hours.and then take the specimen out and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition. (in accordance with MIL-STD-883F : 1004.7)	
10.4 Temperature Cycle Test	The specimen is measured for its frequency and resistance before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + 125 ± 3 °C (15± 3 min). $2\sim3$ min. $2\sim3$ min. Low temp55 ±3 °C (15± 3 min). Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . (in accordance with MIL-STD-883F : 1010.8)	